



CE EMC
TEST REPORT

For

Panel PC

Model: PPC-154T

Trade Name: ADVANTECH

Issued for

Advantech Co., Ltd.
No. 1, Alley 20, Lane 26, Rueiguang Road, Neihu District,
Taipei 114, Taiwan, R.O.C.

Issued by

Compliance Certification Services Inc.
No. 81-1, Lane 210, Bade Rd., 2, Luchu Hsiang,
Taoyuan Hsien, (338) Taiwan, R.O.C.
TEL: 886-3-324-0332
FAX: 886-3-324-5235



***Note:** This report shall not be reproduced except in full, without the written approval of Compliance Certification Services Inc. Ltd. This document may be altered or revised by Compliance Certification Services Inc. personnel only, and shall be noted in the revision section of the document.*



TABLE OF CONTENTS

1	TEST RESULT CERTIFICATION	3
2	EUT DESCRIPTION.....	4
3	TEST METHODOLOGY.....	6
3.1	EUT SYSTEM OPERATION.....	6
3.2	DECISION OF FINAL TEST MODE.....	6
4	SETUP OF EQUIPMENT UNDER TEST.....	7
5	FACILITIES AND ACCREDITATIONS.....	8
5.1	FACILITIES.....	8
5.2	LABORATORY ACCREDITATIONS AND LISTINGS	9
6	INSTRUMENT AND CALIBRATION.....	10
6.1	MEASURING INSTRUMENT CALIBRATION.....	10
6.2	TEST AND MEASUREMENT EQUIPMENT	10
7	LINE CONDUCTED & RADIATED EMISSION TEST.....	13
7.1	LIMIT	13
7.2	TEST PROCEDURE OF LINE CONDUCTED EMISSION.....	14
7.3	TEST PROCEDURE OF COMMON MODE CONDUCTED EMISSION FOR TELECOMMUNICATION PORT	15
7.4	TEST PROCEDURE OF RADIATED EMISSION.....	16
7.5	TEST RESULTS	18
8	POWER HARMONICS TEST.....	24
9	POWER VOLTAGE FLUCTUATION / FLICKER TEST	26
10	ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST	28
11	RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST	32
12	FAST TRANSIENTS/BURST IMMUNITY TEST.....	36
13	SURGE IMMUNITY TEST.....	38
14	CONDUCTED DISTURBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST	40
15	POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST.....	42
16	VOLTAGE DIPS / SHORT INTERRUPTIONS	44
	APPENDIX I - PHOTOGRAPHS OF TEST SETUP	46
	APPENDIX II – TEST RESULT OF EN 61000-3-2/-3	55



1 TEST RESULT CERTIFICATION

Applicant: Advantech Co., Ltd.
No. 1, Alley 20, Lane 26, Rueiguang Road, Neihu District,
Taipei 114, Taiwan, R.O.C.

Manufacturer: Advantech Co., Ltd.
No. 1, Alley 20, Lane 26, Rueiguang Road, Neihu District,
Taipei 114, Taiwan, R.O.C.

Equipment Under Test: Panel PC

Trade Name: ADVANTECH

Model: PPC-154T

Detailed EUT Description: See Item 2 of this report

Date of Test: October 16 ~ 24, 2003

Deviation: None

Applicable Standard	Class/Limit/Criterion	Test Result
EN 55022: 1998	Class B	No non-compliance noted
EN 61000-3-2:1995 + A1: 1998 + A2: 1998	Class A	No non-compliance noted
EN 61000-3-3:1995	Limit	No non-compliance noted
EN 55024:1998, including		
IEC 61000-4-2: 2001	Criterion B	No non-compliance noted
IEC 61000-4-3: 1995	Criterion A	No non-compliance noted
IEC 61000-4-4: 1995	Criterion B	No non-compliance noted
IEC 61000-4-5: 1995	Criterion B	No non-compliance noted
IEC 61000-4-6: 1996	Criterion A	No non-compliance noted
IEC 61000-4-8: 1993	Criterion A	No non-compliance noted
IEC 61000-4-11: 1994	Criterion B/C/C	No non-compliance noted
Deviation from Applicable Standard		
None		

The above equipment was tested by Compliance Certification Services Inc. for compliance with the requirements set forth in the EMC Directive 89/336/EMC and the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved by:

Jonson Lee
Director of Linkou Laboratory
Compliance Certification Services Inc.

Reviewed by:

Jessie Wang
Section Manager of Linkou Laboratory
Compliance Certification Services Inc.



2 EUT DESCRIPTION

Product	Panel PC		
Trade Name	ADVANTECH		
Model	PPC-154T		
Housing Type	Plastic		
EUT Power Rating	AC 100-240V, 50-60Hz		
AC Power Supply Manufacturer	FSP	Model	FSP200-50PLA
AC Power Cord Type	Unshielded, 1.8m (Non-detachable)		
CPU Manufacturer	Intel	Model	P4 2.4GHz
OSC/Clock Frequencies	133MHz		
Memory Capacity	512MB		
HDD Manufacturer	Fujitsu	Model	MHT2020AT (20GB)
FDD Manufacturer	NEC	Model	FD3238T
CD-ROM Manufacturer	QSI	Model	SCR-242
LCD Panel Manufacturer	CHUNGHWA	Model	CLAA150XG01

**I/O Port of EUT**

I/O Port Type	Q'TY	TESTED WITH
1). Parallel Port	1	1
2). Serial Port	2	2
3). PS/2 Keyboard Port	1	1
4). PS/2 Mouse Port	1	1
5). Video Port (VGA)	1	1
6). Line In Port	1	1
7). Line Out Port	1	1
8). Microphone Port	1	1
9). LAN Port	1	1
10). USB Port	4	4
11). 1394 Port	2	2
12). S-Video Out Port	1	1



3 TEST METHODOLOGY

3.1 EUT SYSTEM OPERATION

1. EMI test program was loaded and executed in Windows 98 mode.
2. The EMI test program sequentially exercised all I/O'S of EUT.
3. A communicated software was loaded and executed to communicate between EUT and remote side.
4. The EUT receives message from remote side, and filling the screen of EUT and monitor with upper case of "H" patterns.
5. Repeat 2 to 4.

Note: Test program is self-repeating throughout the test.

3.2 DECISION OF FINAL TEST MODE

1. The following test mode(s) were scanned during the preliminary test:

Mode 1

1024 × 768 Resolution – 100Mbps

Mode 2

1024 × 768 Resolution – 10Mbps

Mode 3

800 × 600 Resolution – 100Mbps

2. After the preliminary scan, the following test mode was found to produce the highest emission level.

Mode 1

Then, the EUT configuration and cable configuration of the above highest emission mode was chosen for all final test items.



4 SETUP OF EQUIPMENT UNDER TEST

Setup Diagram

See test photographs attached in Appendix 1 for the actual connections between EUT and support equipment.

Support Equipment

No.	Equipment	Model No.	Serial No.	FCC ID	Trade Name	Data Cable	Power Cord
1.	Monitor	959NF	AQ19H2RT706132L	FCC DoC	SAMSUNG	Shielded, 1.8m with two cores	Unshielded, 1.8m
2.	Modem	DM-1414	0304012264	IFAXDM1414	ACEEX	Shielded, 1.8m	Unshielded, 1.8m
3.	Modem	DM-1414	0304012269	IFAXDM1414	ACEEX	Shielded, 1.8m	Unshielded, 1.8m
4.	Printer	STYLUS C60	DR3K039425	FCC DoC	EPSON	Shielded, 1.8m	Unshielded, 1.8m
5.	PS/2 Keyboard	KB-0133	N/A	FCC DoC	Compaq	Shielded, 1.8m	N/A
6.	PS/2 Mouse	M-S69	N/A	FCC DoC	Compaq	Shielded, 1.8m	N/A
7.	V8	CCD-TRV310	N/A	FCC DoC	SONY	S-Video Cable: Shielded, 1.5m	N/A
8.	USB 2.0 External HDD	F12-U	A0100214-31d0028	FCC DoC	TeraSyS	Shielded, 1.8m	N/A
9.	USB 2.0 External HDD	F12-U	A0100214-31d0014	FCC DoC	TeraSyS	Shielded, 1.8m	N/A
10.	USB 2.0 External HDD	F12-U	A0100214-2Bq0039	FCC DoC	TeraSyS	Shielded, 1.8m	N/A
11.	USB 2.0 External HDD	F12-U	A0100214-33i0019	FCC DoC	TeraSyS	Shielded, 1.8m	N/A
12.	USB 2.0 External HDD	Combo MO 1.3GB	N/A	FCC DoC	Fujitsu	1394 Cable: Shielded, 1.8m	Unshielded, 1.8m
13.	USB 2.0 External HDD	ST320410A	N/A	N/A	SEAGATE	1394 Cable: Shielded, 1.8m	Unshielded, 1.8m
14.	Walkman	RQ-L10	HB003969	N/A	Panasonic	Unshielded, 1.8m	N/A
15.	Multimedia Earphone	Axis-301	N/A	FCC DoC	Labtec	Unshielded, 1.8m	N/A
16.	HUB (Remote)	TL-5008DS	XT942040616	N/A	Link Pro	LAN Cable Unshielded, 10m	Unshielded, 1.8m
17.	Notebook PC (Remote)	M285	NU2503544	FCC DoC	LEO	LAN Cable: Unshielded, 1.5m	AC Cable: Unshielded, 1.8m DC Cable: Unshielded, 1.8m with a core

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.



5 FACILITIES AND ACCREDITATIONS








5.1 FACILITIES

All measurement facilities used to collect the measurement data are located at CCS Taiwan Linkou Lab at No. 81-1, Lane 210, Bade Rd., 2, Luchu Hsiang, Taoyuan Hsien, Taiwan.

The measurement facilities are constructed in conformance with the requirements of CISPR 16-1, ANSI C63.4 and other equivalent standards.

5.2 LABORATORY ACCREDITATIONS AND LISTINGS

The test facilities used to perform Electromagnetic compatibility tests are registered or accredited by the organizations listed in the following table which includes the recognized scope specifically.

Country	Agency	Scope of Accreditation	Logo
USA	NVLAP	EN 55011, EN 55014-1, AS/NZS 1044, CNS 13783-1, EN 55022, CNS 13438, EN 61000-3-2, EN 61000-3-3, ANSI C63.4, FCC OST/MP-5, AS/NZS 3548 IEC 61000-4-2, IEC 61000-4-3, IEC 61000-4-4, IEC 61000-4-5, IEC 61000-4-6, IEC 61000-4-8, IEC 61000-4-11	 200600-0
USA	FCC	3/10 meter Open Area Test Sites to perform FCC Part 15/18 measurements	 93105, 90471
Japan	VCCI	3/10 meter Open Area Test Sites and conducted test sites to perform radiated/conducted measurements	 R-393/1066/725/879 C-402/747/912
Norway	NEMKO	EN 50081-1/2, EN 50082-1/2, IEC 61000-6-1/2, EN 50091-2, EN 50130-4, EN 55011, EN 55013, EN 55014-1/2, EN 55015, EN 55022, EN 55024, EN 61000-3-2/3, EN 61326-1, IEC 61000-4-2/3/4/5/6/8/11, EN 60601-1-2, EN 300 328-2, EN 300 422-2, EN 301 419-1, EN 301 489-01/03/07/08/09/17, EN 301 419-2/3, EN 300 454-2, EN 301 357-2	 ELA 124a ELA 124b ELA 124c
Taiwan	CNLA	EN 300 328-1, EN 300 328-2, EN 300 220-1, EN 300 220-2, EN 300 220-3, 47 CFR FCC Part 15 Subpart C, EN 61000-3-2, EN 61000-3-3, CNS 13439, CNS 13783-1, CNS 14115, CNS 13438, AS/NZS 3548, CNS 13022-1, IEC 1000-4-3/4/5/6/8/11, CNS 13022-2/3	 0 3 6 3 ILAC MRA
Taiwan	BSMI	CNS 13438, CNS 13783-1, CNS 13439, CNS 14115	 SL2-IS-E-0014 / IN-E-0014 /A1-E-0014 /R1-E-0014 /R2-E-0014 /L1-E-0014
Canada	Industry Canada	RSS212, Issue 1	 IC 3991-3 IC 3991-4

Note: No part of this report may be used to claim or imply product endorsement by CNLA, NVLAP or other government agency.



6 INSTRUMENT AND CALIBRATION

6.1 MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

6.2 TEST AND MEASUREMENT EQUIPMENT

The following list contains measurement equipment used for testing. The equipment conforms to the requirement of CISPR 16-1, ANSI C63.2 and other required standards.

Calibration of all test and measurement, including any accessories that may effect such calibration, is checked frequently to ensure the accuracy. Adjustments are made and correction factors are applied in accordance with the instructions contained in the respective manual.

Equipment Used for Emission Measurement

Conducted Emission Test Site # 3				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
EMI Test Receiver	R&S	ESHS30	828144/003	08/07/2004
LISN	R&S	ESH2-Z5	843285/010	01/19/2004
LISN	EMCO	3825/2	9003-1628	07/27/2004
Spectrum Analyzer	ADVANTEST	R3261A	91720031	N.C.R
2X2 WIRE ISN	R&S	ENY22	100020	06/27/2004
FOUR WIRE ISN	R&S	ENY41	100006	06/27/2004

Note: The measurement uncertainty is less than +/- 2.83dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.



Open Area Test Site # 4				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	ADVANTEST	R3132	91700456	N.C.R
EMI Test Receiver	R&S	ESVS10	846285/016	04/10/2004
Bilog Antenna	CHASE	CBL 6112B	2462	01/10/2004
Turn Table	Chance most	N/A	N/A	N.C.R
Antenna Tower	Chance most	N/A	N/A	N.C.R
Controller	Chance most	N/A	N/A	N.C.R
RF Switch	ANRITSU	MP59B	M51067	N.C.R
Site NSA	C&C Lab.	N/A	N/A	08/08/2004

Note: The measurement uncertainty is less than +/- 3.36dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.

Power Harmonic & Voltage Fluctuation/Flicker Measurement (EN 61000-3-2&-3-3)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
Harmonic & Flicker Tester	HAEFELY TRENCH	PHF555	080 419-25	09/25/2004

Equipment Used for Immunity Measurement

ESD Test Site (IEC/EN 61000-4-2)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
ESD Generator	SCHAFFNER	NSG438	170	04/23/2004

Radiated Electromagnetic Field Immunity Test Site (IEC/EN 61000-4-3)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
S.G.	R&S	SMY02	100094	08/05/2004
Power Meter	R&S	NRVD	837794/029	N.C.R.
Power Amplifier	ar	150W1000	300300	N.C.R
Power Antenna	EMCO	93141	9712-1083	N.C.R



Fast Transients/Burst Test Site (IEC/EN 61000-4-4)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
Fast Transients/Burst Generator	HAEFELY TRENCH	PEFT- JUNIOR	583 333-117	08/19/2004
Clamp	HAEFELY TRENCH	093 506.1	080 421.13	N.C.R

Surge Immunity Test Site (IEC/EN 61000-4-5)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
Surge Tester	HAEFELY TRENCH	PSUGER 4010	583 334-71	08/19/2004

CS Test Site (IEC/EN 61000-4-6)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
S.G.	R&S	SMY02	100094	08/05/2004
Power Amplifier	ar	500A100A	300299	N.C.R
CDN	Lüthi	801-M3	1879	02/25/2004
CDN	FRANKONIA	CDN-M2	A3002010	04/27/2004
CDN	SCHAFFNER	T400	16906	10/16/2003

Power Frequency Magnetic Field Immunity Test Site (IEC/EN 61000-4-8)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
TRIAX ELF Magnetic Field Meter	F.W.BELL	4090	9711	10/20/2004
Magnetic Field Tester	HAEFELY TRENCH	MAG 100.1	080 938-01	N.C.R

Voltage Dips/Short Interruption and Voltage Variation Immunity Test Site (IEC/EN 61000-4-11)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
Dips/Interruption and Variations Simulator	HAEFELY TRENCH	PLINE 1610	080 344-05	03/27/2004

7 LINE CONDUCTED & RADIATED EMISSION TEST

7.1 LIMIT

Maximum permissible level of Line Conducted Emission

Frequency (MHZ)	Class A (dBuV)		Class B (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	79	66	66 - 56	56 - 46
0.50 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

Note: The lower limit shall apply at the transition frequency.

Maximum permissible level of Common Mode Conducted Emission (Telecommunication Ports)

CLASS A

Frequency (MHZ)	Voltage Limit (dBuV)		Current Limit (dBuA)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	97 – 87	84 - 74	53 – 43	40 – 30
0.5 - 30.0	87	74	43	30

Note: The lower limit shall apply at the transition frequency.

CLASS B

Frequency (MHZ)	Voltage Limit (dBuV)		Current Limit (dBuA)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	84 - 74	74 - 64	40 – 30	30 – 20
0.5 - 30.0	74	64	30	20

Note: The lower limit shall apply at the transition frequency.

Maximum permissible level of Radiated Emission measured at 10 meter

Frequency (MHZ)	Class A (dBuV/m)	Class B (dBuV/m)
	Quasi-peak	Quasi-peak
30 – 230	40	30
230 - 1000	47	37

Note: The lower limit shall apply at the transition frequency.



7.2 TEST PROCEDURE OF LINE CONDUCTED EMISSION

Procedure of Preliminary Test

- The EUT was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- The test equipment EUT installed received AC power, 230VAC/50Hz, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment received power from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test.
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission level were recorded for reference of the final test.

Procedure of Final Test

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less -2dB to the Average limit in Q.P. mode, then the emission signal was re-checked using an Average detector.
- The test data of the worst-case condition(s) was recorded.

**Data Sample:**

Freq. (MHz)	Q.P. Raw (dBuV)	Average Raw (dBuV)	Q.P. Limit (dBuV)	Average Limit (dBuV)	Q.P. Margin (dB)	Average Margin (dB)	Note
x.xx	43.95	---	56.00	46.00	-12.05	---	L1

Freq. = Emission frequency in MHz

Raw dBuV = Uncorrected Analyzer/Receiver reading + Insertion loss of LISN, if it > 0.5 dB

Limit dBuV = Limit stated in standard

Margin dB = Reading in reference to limit

Note = Current carrying line of reading

“---“ = The emission level complied with the Average limits, with at least 2dB margin limits, so no further recheck.

Calculation Formula

Margin (dB) = RAW (dBuV) – Limit (dBuV)

7.3 TEST PROCEDURE OF COMMON MODE CONDUCTED EMISSION FOR TELECOMMUNICATION PORT

- Selecting ISN for unscreened cable or a current probe for screened cable to take measurement.
- The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.
- Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.
- Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- In case of measuring on the screened cable, the current limit shall be applied, otherwise the voltage limit should be applied.
- The following test mode was scanned during the preliminary test:

Mode 1**10/100 Mbps**

- After the preliminary scan, we found the following test mode producing the highest emission level and test data of the worst case was recorded.

Mode 1

**Data Sample:**

Freq. (MHz)	Q.P. Raw (dBuV)	AV. Raw (dBuV)	Q.P. Limit (dBuV)	AV. Limit (dBuV)	Q.P. Margin (dB)	AV. Margin (dB)	Note
x.xx	43.95	---	87.00	74.00	-43.05	---	---

Freq.: Emission frequency

Raw: Uncorrected Analyzer / Receiver reading

Limit: Limit stated in standard

Margin: Reading in reference to limit

Note: Current carrying line of reading

“ - “: The emission level complied with the Average limits, with at least 2 dB margin, so no further recheck.

7.4 TEST PROCEDURE OF RADIATED EMISSION

Procedure of Preliminary Test

- The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical usage as per EN 55022.
- The EUT received AC power source, 230VAC/50Hz, from the outlet socket under the turntable. All support equipment received power from another socket under the turntable.
- The antenna was placed at 10 meter away from the EUT as stated in EN 55022. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
- The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test:
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.

**Procedure of Final Test**

- EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.
- The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.
- The test data of the worst-case condition(s) was recorded.

Data Sample:

Freq. (MHz)	Raw Data (dBuV)	Corr. Factor (dB/m)	Emiss. Level (dBuV/m)	Limits (dBuV/m)	Margin (dB)
xx.xx	14.00	12.20	26.20	30.00	-3.80

Freq.	= Emission frequency in MHz
Raw Data (dBuV)	= Uncorrected Analyzer / Receiver reading
Corr. Factor (dB/m)	= Antenna factor + Cable loss – Amplifier gain
Emiss. Level (dBuV/m)	= Raw reading converted to dBuV/m and CF added
Limit (dBuV/m)	= Limit stated in standard
Margin (dB)	= Reading in reference to limit
P	= Peak Reading
Q	= Quasi-peak Reading
A	= Average Reading

Calculation Formula

Margin (dB) = Emiss. Level (dBuV/m) – Limits (dBuV/m)

Emission Level (dBuV/m) = Raw Data (dBuV) + Corr. Factor (dB/m)



7.5 TEST RESULTS

Line Conducted Emission

Model: PPC-154T**Test Mode:** Mode 1**Temperature:** 32°C**Humidity:** 67% RH**Tested by:** Michael Chen**Test Results:** Passed

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Q.P. Raw (dBuV)	AVG Raw (dBuV)	Q.P. Limit (dBuV)	AVG Limit (dBuV)	Q.P. Margin (dB)	AVG Margin (dB)	NOTE
0.215	50.00	---	63.01	53.01	-13.01	---	L1
0.995	40.90	---	56.00	46.00	-15.10	---	L1
6.740	39.60	---	60.00	50.00	-20.40	---	L1
7.310	41.80	---	60.00	50.00	-18.20	---	L1
9.510	40.70	---	60.00	50.00	-19.30	---	L1
10.360	41.00	---	60.00	50.00	-19.00	---	L1
0.215	49.80	---	63.01	53.01	-13.21	---	L2
0.990	38.10	---	56.00	46.00	-17.90	---	L2
6.540	39.60	---	60.00	50.00	-20.40	---	L2
7.890	43.10	---	60.00	50.00	-16.90	---	L2
8.530	41.30	---	60.00	50.00	-18.70	---	L2
10.800	41.70	---	60.00	50.00	-18.30	---	L2

L1 = Line One (Live Line) / L2 = Line Two (Neutral Line)

Note: "----" denotes the emission level was or more than 2dB below the Average limit, so no re-check anymore.

**Common Mode Conducted Emission****Model:** PPC-154T**Test Mode:** Mode 1**Temperature:** 28°C**Humidity:** 69% RH**Tested by:** Michael Chen**Test Results:** Passed

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Q.P. Raw (dBuV)	AVG Raw (dBuV)	Q.P. Limit (dBuV)	AVG Limit (dBuV)	Q.P. Margin (dB)	AVG Margin (dB)	NOTE
3.750	56.70	---	74.00	64.00	-17.30	---	10Base
6.250	55.90	---	74.00	64.00	-18.10	---	10Base
7.550	55.70	---	74.00	64.00	-18.30	---	10Base
8.750	60.80	---	74.00	64.00	-13.20	---	10Base
11.250	63.50	57.50	74.00	64.00	-10.50	-6.50	10Base
12.510	59.60	---	74.00	64.00	-14.40	---	10Base
13.420	58.60	---	74.00	64.00	-15.40	---	100Base
16.230	60.50	---	74.00	64.00	-13.50	---	100Base
18.240	57.30	---	74.00	64.00	-16.70	---	100Base
19.710	57.20	---	74.00	64.00	-16.80	---	100Base
23.130	57.60	---	74.00	64.00	-16.40	---	100Base
26.610	57.30	---	74.00	64.00	-16.70	---	100Base

L1 = Line One (Live Line) / L2 = Line Two (Neutral Line)

Note: "---" denotes the emission level was or more than 2dB below the Average limit, so no re-check anymore.

**Radiated Emission (A)****Model:** PPC-154T**Test Mode:** Mode 1**Temperature:** 31°C**Humidity:** 65% RH**Detector Function:** Quasi-peak.**Antenna:** Vertical at 10m**Tested by:** Michael Chen**Test Results:** Passed

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Raw Data (dBuV)	Corr. Factor (dB/m)	Emiss. Level (dBuV/m)	Limits (dBuV/m)	Margin (dB)
65.00	19.6	7.9	27.5	30.0	-2.5
80.10	18.6	9.2	27.8	30.0	-2.2
115.03	13.5	14.3	27.8	30.0	-2.2
130.02	12.5	14.3	26.8	30.0	-3.2
134.98	11.8	14.2	26.0	30.0	-4.0
146.29	13.6	13.9	27.5	30.0	-2.5
167.04	12.5	13.0	25.5	30.0	-4.5
173.19	13.4	12.6	26.0	30.0	-4.0
201.61	14.7	12.7	27.4	30.0	-2.6
204.21	11.5	12.7	24.2	30.0	-5.8
214.53	13.7	12.8	26.5	30.0	-3.5
227.54	12.1	13.2	25.3	30.0	-4.7



233.50	17.7	14.1	31.8	37.0	-5.2
<hr/>					
260.03	14.3	17.1	31.4	37.0	-5.6
<hr/>					
552.59	9.0	25.2	34.2	37.0	-2.8
<hr/>					
601.36	8.8	24.2	33.0	37.0	-4.0
<hr/>					
731.38	8.0	25.5	33.5	37.0	-3.5
<hr/>					

**Radiated Emission (B)****Model:** PPC-154T**Test Mode:** Mode 1**Temperature:** 31°C**Humidity:** 65% RH**Detector Function:** Quasi-peak.**Antenna:** Horizontal at 10m**Tested by:** Michael Chen**Test Results:** Passed

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Raw Data (dBuV)	Corr. Factor (dB/m)	Emiss. Level (dBuV/m)	Limits (dBuV/m)	Margin (dB)
65.00	17.6	7.9	25.5	30.0	-4.5
73.46	18.4	8.8	27.2	30.0	-2.8
80.32	18.6	9.2	27.8	30.0	-2.2
113.77	11.3	14.2	25.5	30.0	-4.5
130.31	10.7	14.3	25.0	30.0	-5.0
134.78	11.3	14.2	25.5	30.0	-4.5
146.30	11.6	13.9	25.5	30.0	-4.5
154.41	14.1	13.6	27.7	30.0	-2.3
166.69	10.8	13.0	23.8	30.0	-6.2
169.04	14.9	12.9	27.8	30.0	-2.2
188.17	13.4	12.4	25.8	30.0	-4.2
201.53	15.0	12.7	27.7	30.0	-2.3



211.29	14.6	12.8	27.4	30.0	-2.6
214.54	15.2	12.8	28.0	30.0	-2.0
227.55	14.7	13.2	27.9	30.0	-2.1
235.69	20.0	14.4	34.4	37.0	-2.6
260.05	17.9	17.1	35.0	37.0	-2.0
268.17	16.0	17.5	33.5	37.0	-3.5
276.29	17.2	17.8	35.0	37.0	-2.0
284.43	16.4	17.9	34.3	37.0	-2.7
300.68	13.6	18.0	31.6	37.0	-5.4
552.58	7.5	25.2	32.7	37.0	-4.3
601.37	10.3	24.2	34.5	37.0	-2.5
675.20	8.8	25.0	33.8	37.0	-3.2
682.60	8.2	25.1	33.3	37.0	-3.7
731.80	7.0	25.5	32.5	37.0	-4.5
747.64	7.8	25.7	33.5	37.0	-3.5
862.66	6.2	27.1	33.3	37.0	-3.7

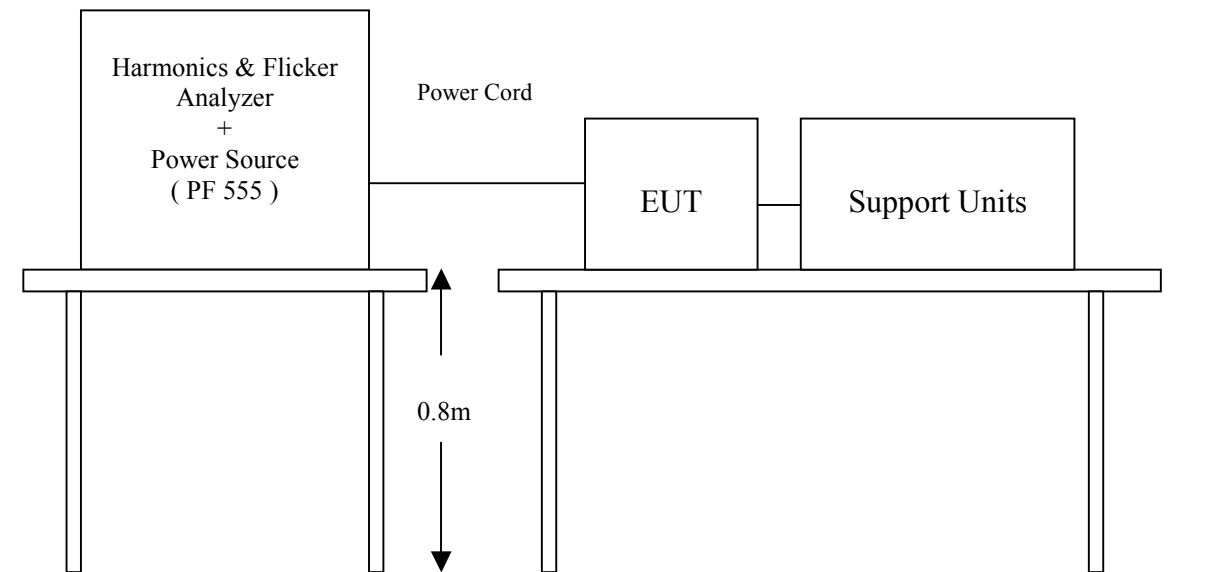


8 POWER HARMONICS TEST

Port : AC mains
Basic Standard : EN 61000-3-2 (1995 + A1: 1998 + A2: 1998)
Limits : ☒ CLASS A ; ☐ CLASS D
Tested by : Michael Chen
Temperature : 23°C
Humidity : 54% RH
Input Current Wave : Without special wave shape

Limit:

Limits for Class A equipment		Limits for Class D equipment		
Harmonics Order n	Max. permissible harmonics current A	Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
Odd harmonics		Odd Harmonics only		
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15<=n<=39	0.15x15/n	15<=n<=39	3.85/n	0.15x15/n
Even harmonics				
2	1.08			
4	0.43			
6	0.30			
8<=n<=40	0.23x8/n			

Block Diagram of Test Setup:**Test Procedure:**

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

Test Result : (See Appendix II for details)***PASS******FAIL***

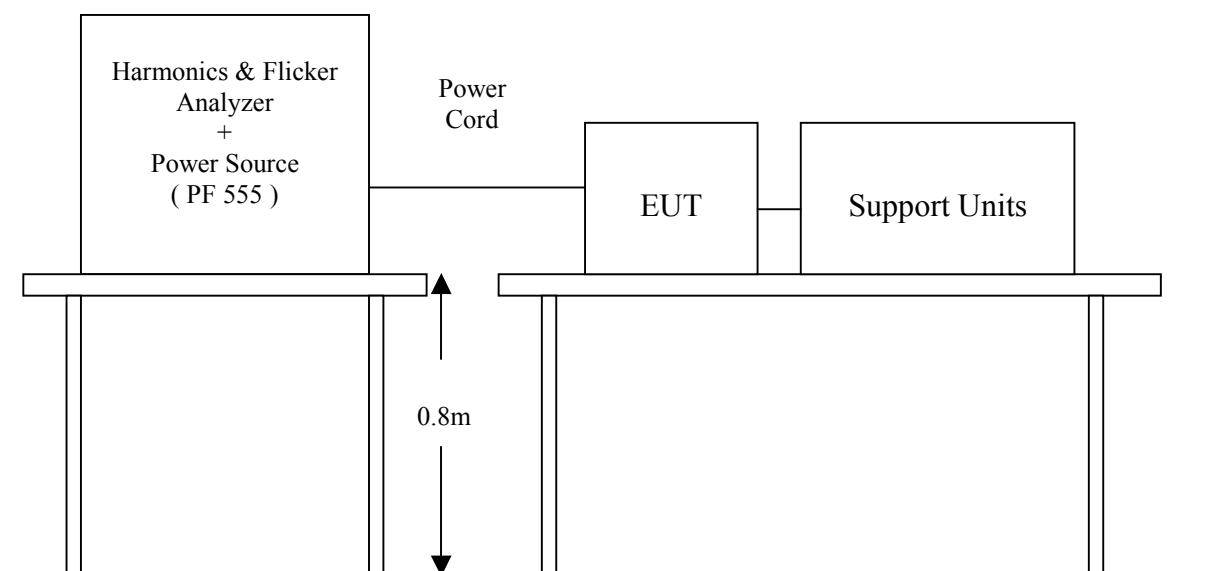
9 POWER VOLTAGE FLUCTUATION / FLICKER TEST

Port : AC mains
Basic Standard : EN 61000-3-3 (1995)
Limits : §5 of EN 61000-3-3
Tested by : Michael Chen
Temperature : 23°C
Humidity : 54% RH

Limit:

TEST ITEM	LIMIT	REMARK
P_{st}	1.0	P_{st} means short-term flicker indicator.
P_{lt}	0.65	P_{lt} means long-term flicker indicator.
T_{dt} (ms)	200	T_{dt} means maximum time that dt exceeds 3 %.
d_{max} (%)	4%	d_{max} means maximum relative voltage change.
dc (%)	3%	dc means relative steady-state voltage change

Block Diagram of Test Setup:



Test Procedure:

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

Test Result: (See Appendix II for details)

** Continue

Test Parameter	Measurement Value	Limit	Result
P _{st}	0.016	1.0	Pass
P _{lt}	0.016	0.65	Pass
T _{dt} (ms)	5	200	Pass
d _{max} (%)	0.04%	4%	Pass
dc (%)	0.03%	3%	Pass

** Manual Switch

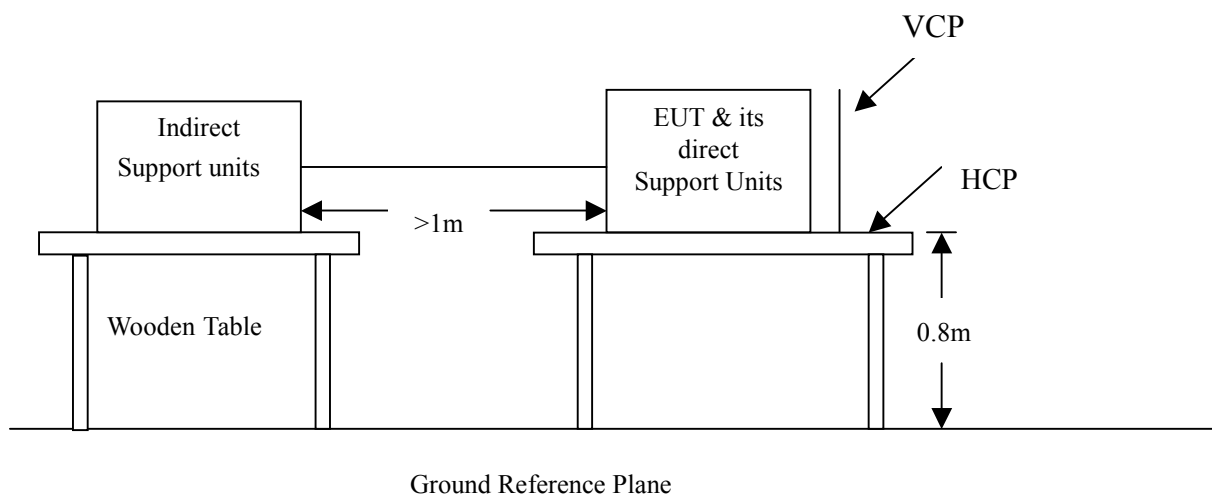
Test Parameter	Measurement Value	Limit	Result
P _{st}	0.025	1.0	Pass
P _{lt}	0.025	0.65	Pass
T _{dt} (ms)	8	200	Pass
d _{max} (%)	0.009%	4%	Pass
dc (%)	0.009%	3%	Pass

10 ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port	: Enclosure
Basic Standard	: IEC/EN 61000-4-2
Test Level	: ± 8 kV (Air Discharge) ± 4 kV (Contact Discharge) ± 4 kV (Indirect Discharge)
Performance Criterion	: B (Standard Required)
Tested by	: Vic Wang
Temperature	: 25°C
Humidity	: 51% RH
Pressure	: 1019mbar

Block Diagram of Test Setup:

(The 470 k ohm resistors are installed per standard requirement.)



**Test Procedure:**

1. The EUT was located 0.1 m minimum from all side of the HCP.
2. The indirect support units were located 1 m minimum away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.
3. A scroll 'H' test program was loaded and executed in Windows 98 mode.
4. The EUT sent above message to LCD Panel of EUT and monitor related peripherals through the test.
5. Active the communication function if the EUT with such port(s).
6. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
7. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
8. The application of ESD to the contact of open connectors is not required.
9. The EUT direct connection units also need to be applied ESD at the port of EUT cable connected.
10. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

Note: As per IEC/EN 61000-4-2, two 470k bleed resistors cable is connected between the EUT and HCP during the test applicable for power ungrounded or battery operating unit only.

The electrostatic discharges were applied as follows:

Amount of discharge	Voltage	Coupling	Result (Pass/Fail)
Mini 10 /Point	± 8 kV	Air Discharge	Pass
Mini 25 /Point	± 4 kV	Contact Discharge	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge HCP	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Front)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Right)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Left)	N/A
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Back)	N/A

****For the tested points to EUT, please refer to attached page.**

(Blue arrow mark for Contact Discharge and red arrow mark for Air Discharge)



Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.



PASS



FAIL

Observation: No function degraded during the tests.

The Tested Points of EUT

Photo 1 of 4



Photo 2 of 4

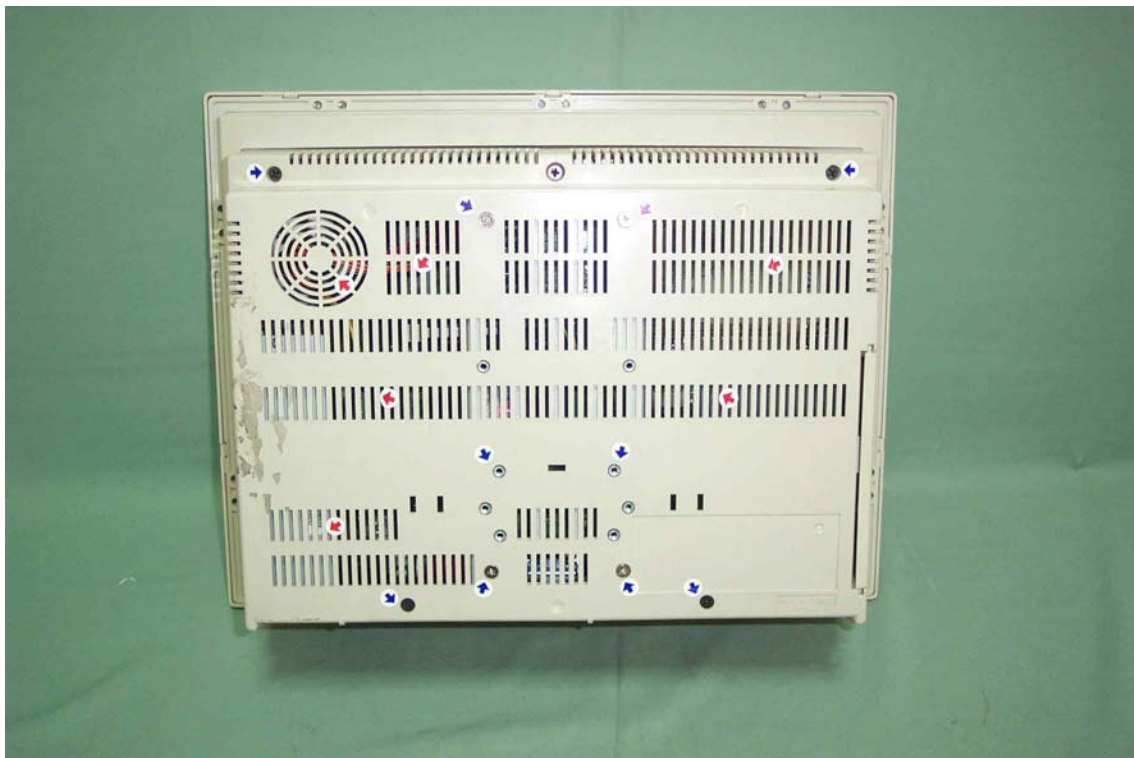


Photo 3 of 4



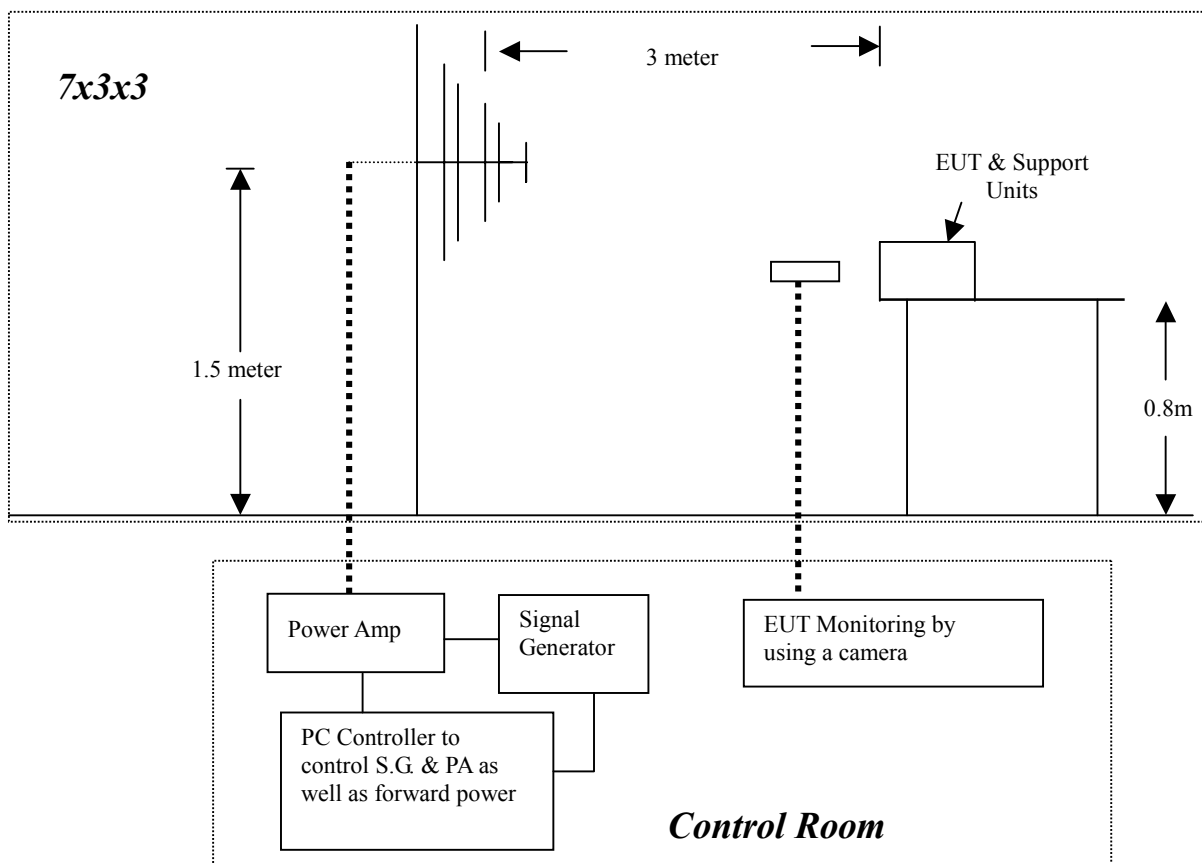
Photo 4 of 4



11 RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port : Enclosure
Basic Standard : IEC/EN 61000-4-3
Requirements : 3 V/m / with 80% AM. 1kHz Modulation.
Performance Criterion : A (Standard Required)
Tested by : Vic Wang
Temperature : 25°C
Humidity : 51% RH
Pressure : 1019mbar

Block Diagram of Test Setup:



**Test Procedure:**

1. The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per IEC/EN 61000-4-3.
2. Setting the testing parameters of RS test software per IEC/EN 61000-4-3.
3. Performing the pre-test at each side of with double specified level (6V/m) at 4% steps.
4. From the result of pre-test in step 5, choice the worst side of EUT for final test from 80 MHz to 1000 MHz at 1% steps.
5. Recording the test result in following table.
6. It is not necessary to perform test as per annex A of EN 55024 if the EUT doesn't belong to ITE product.

Preliminary test conditions:

Test level : 6V/m
Steps : 4 % of fundamental
Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position	Result (Pass/Fail)
80-1000	6V/m	Yes	H	Front	Pass
80-1000	6V/m	Yes	V	Front	Pass
80-1000	6V/m	Yes	H	Right	Pass
80-1000	6V/m	Yes	V	Right	Pass
80-1000	6V/m	Yes	H	Back	Pass
80-1000	6V/m	Yes	V	Back	Pass
80-1000	6V/m	Yes	H	Left	Pass
80-1000	6V/m	Yes	V	Left	Pass

Final test conditions:

Test level : 3V/m
Steps : 1 % of fundamental
Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position	Result (Pass/Fail)
80-1000	3V/m	Yes	H	Front	Pass
80-1000	3V/m	Yes	V	Front	Pass



Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL**

Observation: No function degraded during the tests.

12 FAST TRANSIENTS/BURST IMMUNITY TEST

Port : On Power Supply Lines and LAN Cable

Basic Standard : IEC/EN 61000-4-4

Requirements : ± 1 kV for Power Supply Line
 ± 0.5 kV for LAN Cable

Performance Criteria : B (Standard Required)

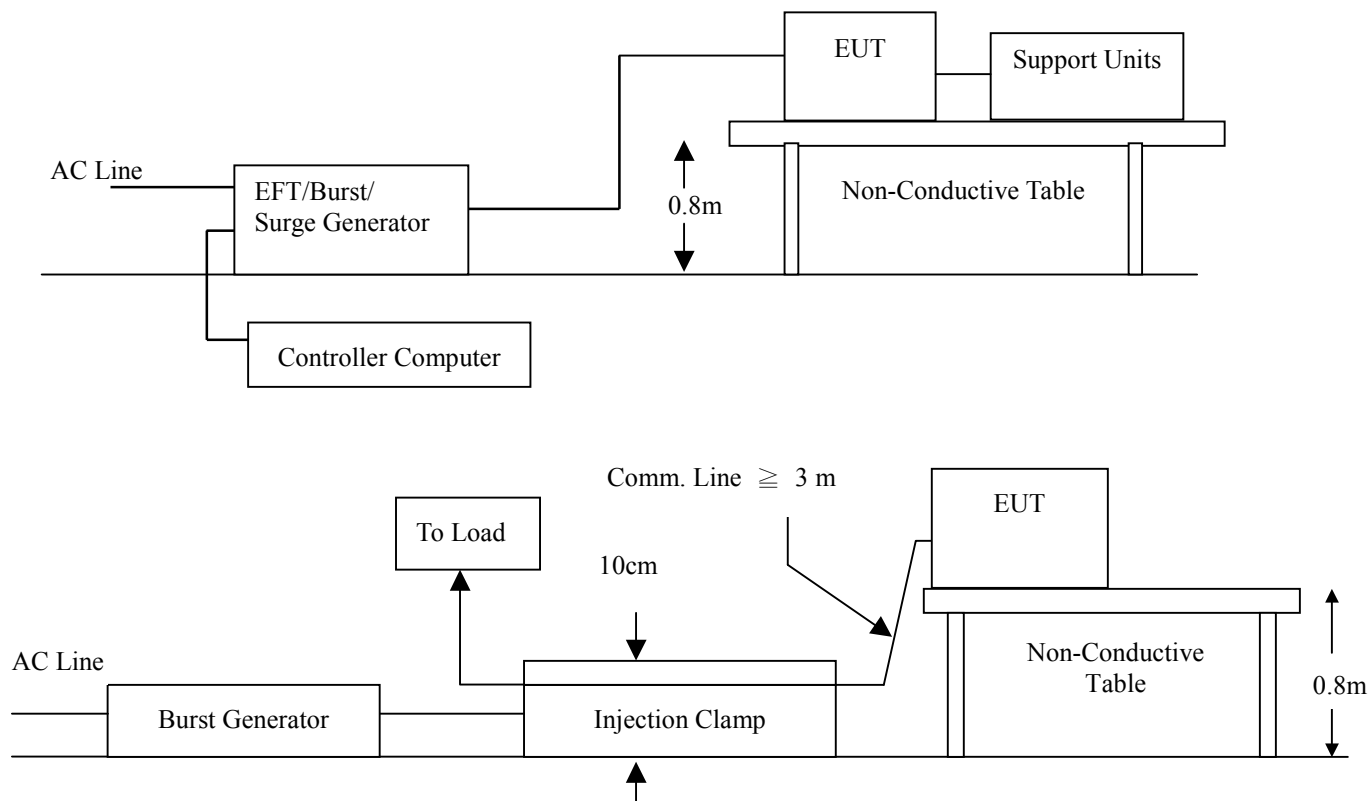
Tested by : Vic Wang

Temperature : 25°C

Humidity : 51% RH

Pressure : 1019mbar

Block Diagram of Test Setup:



Test Procedure:

1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
2. A 1.0 meter long power cord was attached to EUT during the test.
3. The length of communication cable between communication port and clamp was keeping within 1 meter.
4. Injected test voltage to the EUT ports from minimum to standard request or client request.
5. Recording the test result as shown in following table.

**Test conditions:**

Impulse Frequency : 5kHz
Tr/Th : 5/50ns
Burst Duration : 15ms
Burst Period : 3Hz

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	± 1	Direct	Pass
N	± 1	Direct	Pass
PE	± 1	Direct	Pass
L + N	± 1	Direct	Pass
L + PE	± 1	Direct	Pass
N + PE	± 1	Direct	Pass
L + N + PE	± 1	Direct	Pass
RJ 45 Port (LAN Cable)	± 0.5	Clamp	Pass

Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL**

Observation: No function degraded during the tests.

13 SURGE IMMUNITY TEST

Port : Power Cord

Basic Standard : IEC/EN 61000-4-5

Requirements : ± 1 kV (Line to Line)
 ± 2 kV (Line to Ground)

Performance Criteria : B (Standard Required)

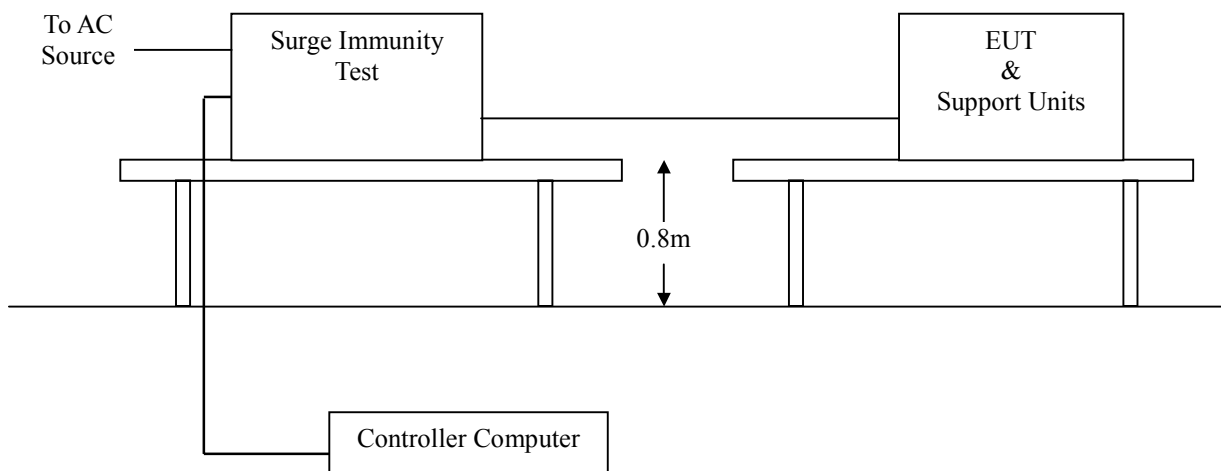
Tested by : Vic Wang

Temperature : 25°C

Humidity : 51% RH

Pressure : 1019mbar

Block Diagram of Test Setup:



Test Procedure:

1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
2. Injected test voltage to the EUT ports from minimum to standard request or client request.
3. Recording the test result as shown in following table.

**Test conditions:**

Voltage Waveform : 1.2/50 μ s
Current Waveform : 8/20 μ s
Polarity : Positive/Negative
Phase angle : 0°, 90°, 270°
Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL**

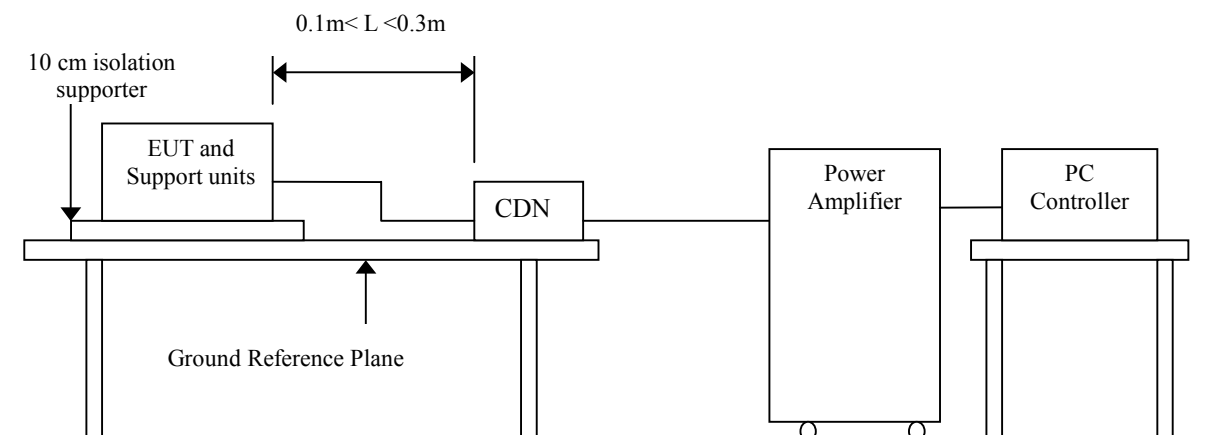
Observation: No function degraded during the tests.

14 CONDUCTED DISTURBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST

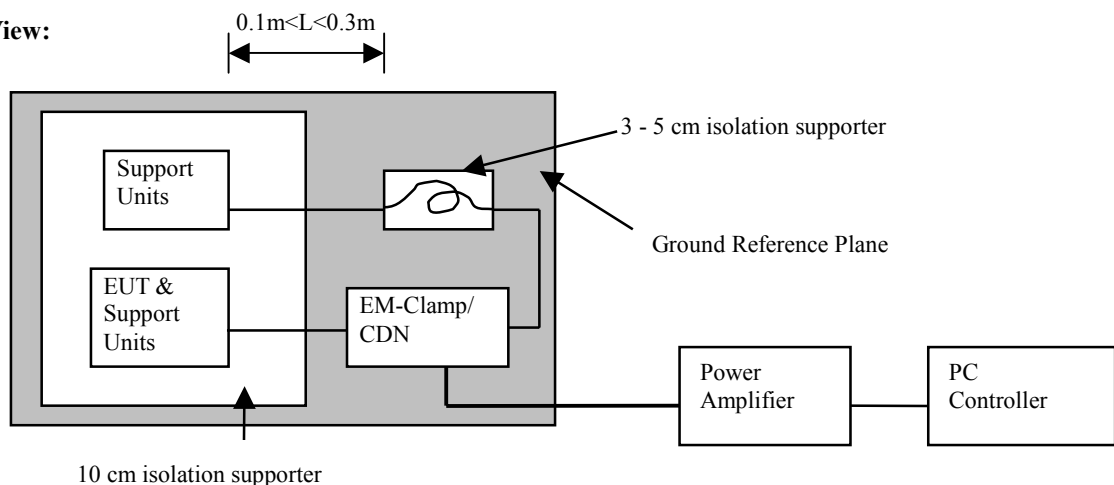
Port	: AC Port and Signal/ LAN Cable
Basic Standard	: IEC/EN 61000-4-6
Requirements	: 3 V with 80% AM. 1kHz Modulation.
Injection Method	: CDN-M3 for Power Cord CDN-T4 for LAN Cable
Performance Criterion	: A (Standard Required)
Tested by	: Vic Wang
Temperature	: 25°C
Humidity	: 51% RH
Pressure	: 1019mbar

Block Diagram of Test Setup:

Side View:



Top View:



**Test Procedure:**

1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
2. Setting the testing parameters of CS test software as per IEC/EN 61000-4-6.
3. Recording the test result in following table.

Test conditions:

Frequency Range : 0.15MHz-80MHz

Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	3V	Yes	Pass

Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL****Observation:** No function degraded during the tests.

15 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

Port : Enclosure

Basic Standard : IEC/EN 61000-4-8

Requirements : 1 A/m

Performance Criterion : A (Standard Required)

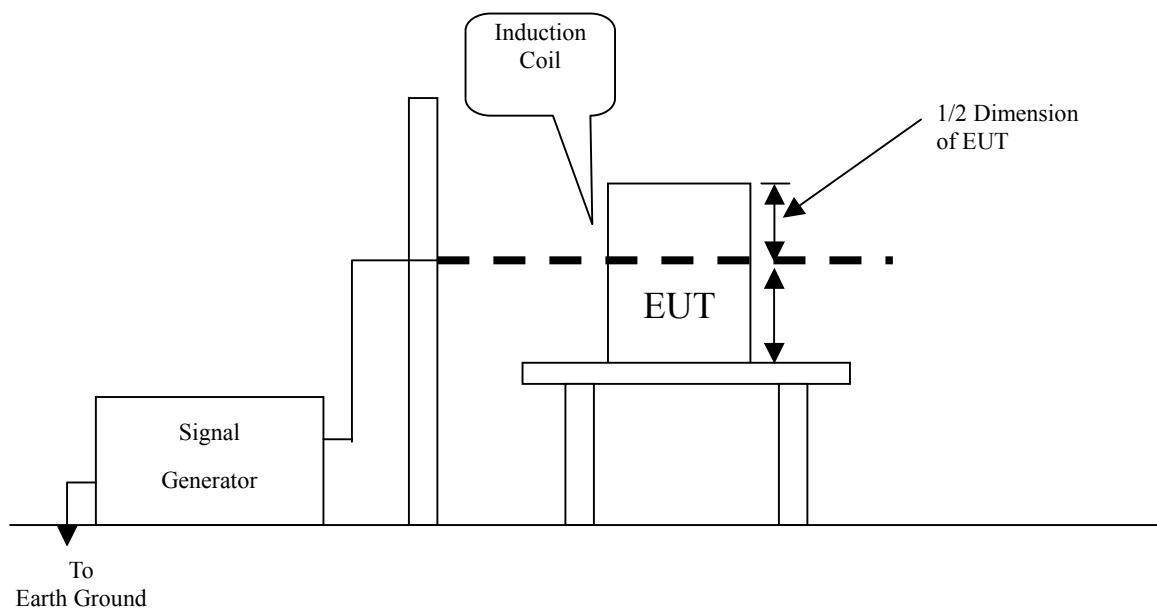
Tested by : Vic Wang

Temperature : 25°C

Humidity : 51% RH

Pressure : 1019mbar

Block Diagram of Test Setup:



Test Procedure:

1. The EUT and support units were located on Ground Reference Plane with the interposition of a 0.1 m thickness insulation support.
2. Putting the induction coil on horizontal direction. (X direction)
3. Rotating the induction coil by 90° (Y direction)
4. Rotating the induction coil by 90° again (Z direction)
5. Recording the test result as shown in following table.

**Test conditions:**

Field Strength: 1A/m
Power Freq.: 50Hz
Orientation: X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark
X	1A/m	Pass	
Y	1A/m	Pass	
Z	1A/m	Pass	

Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL**

Observation: No function degraded during the tests.

16 VOLTAGE DIPS / SHORT INTERRUPTIONS

Port : AC mains

Basic Standard : IEC/EN 61000-4-11

Requirement : PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees

Voltage Dips	Test Level % U_T	Reduction (%)	Duration (periods)	Performance Criteria
	<5	>95	0.5	B
	70	30	25	C

Voltage Interceptions	Test Level % U_T	Reduction (%)	Duration (periods)	Performance Criteria
	<5	>95	250	C

Test Interval : Min. 10 sec.

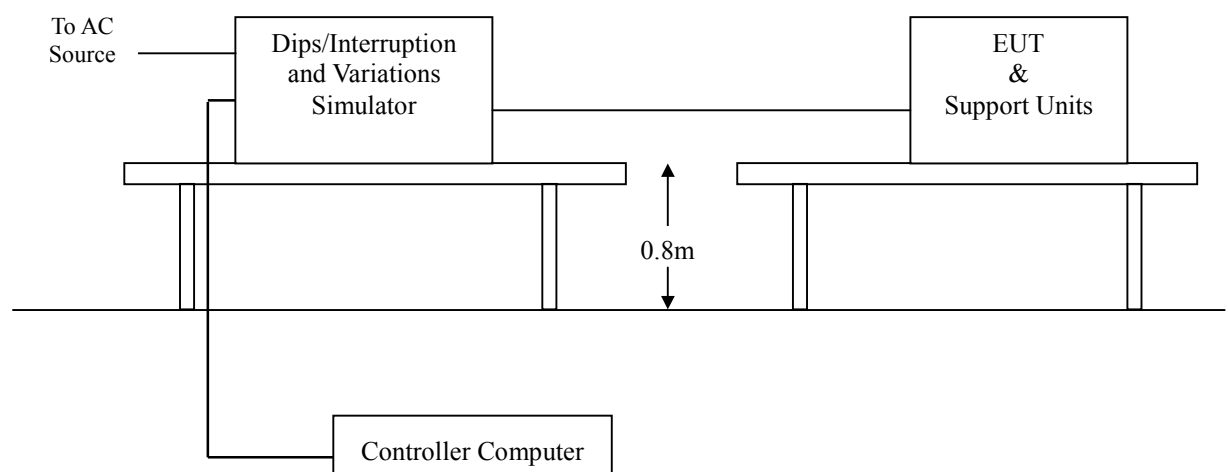
Tested by : Vic Wang

Temperature : 25 °C

Humidity : 51% RH

Pressure : 1019mbar

Block Diagram of Test Setup:



Test Procedure:

1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
2. Setting the parameter of tests and then Perform the test software of test simulator.
3. Conditions changes to occur at 0 degree crossover point of the voltage waveform.
4. Recording the test result in test record form.

**Test conditions**

The duration with a sequence of three dips/interruptions with interval of 10 s minimum
(Between each test event)

Voltage Dips:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria
0	100	0.5	Normal	A
70	30	25	Normal	A

Voltage Interruptions:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria
0	100	250	EUT shut down but can be recovered by manual, as the events disappear.	C

Normal: No any functions degrade during and after the test.

Performance & Result:

Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL**

APPENDIX I - PHOTOGRAPHS OF TEST SETUP

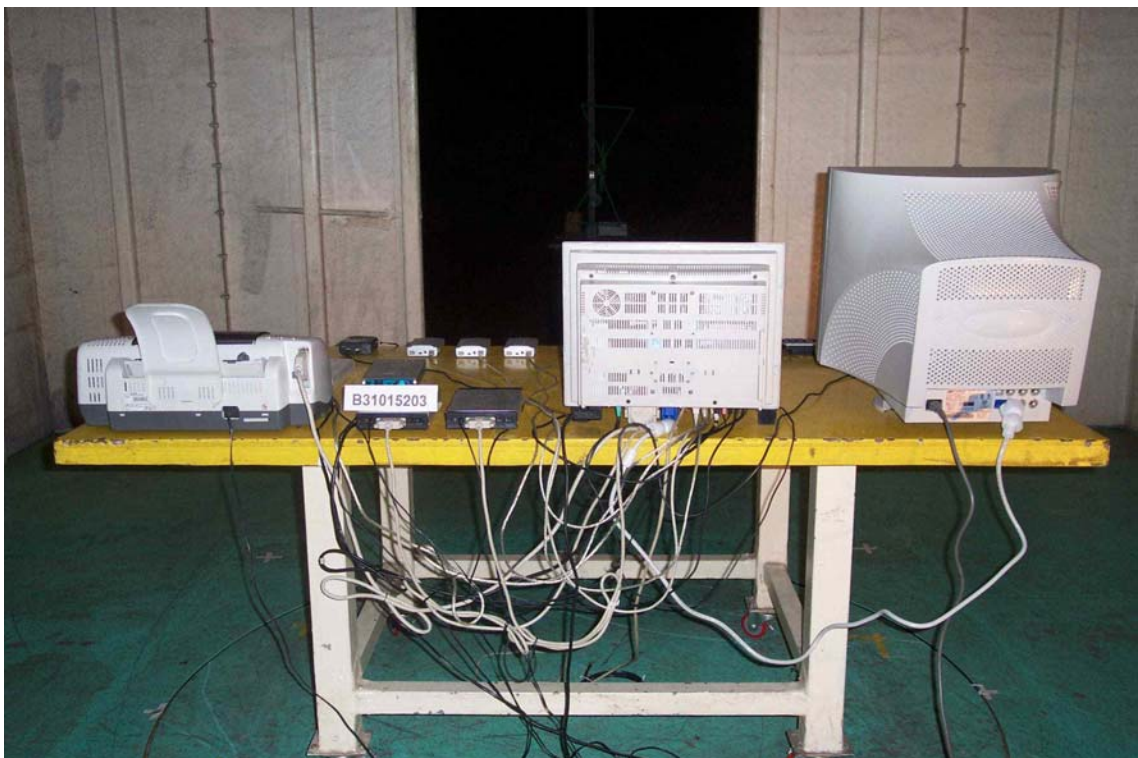
LINE CONDUCTED EMISSION TEST (EN 55022)



COMMON MODE CONDUCTED EMISSION TEST



RADIATED EMISSION TEST (EN 55022)





POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST



ELECTROSTATIC DISCHARGE TEST



RADIATED ELECTROMAGNETIC FIELD TEST



FAST TRANSIENTS/BURST TEST



SURGE IMMUNITY TEST**CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST**

POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST



VOLTAGE DIPS / INTERRUPTION TEST





APPENDIX II – TEST RESULT OF EN 61000-3-2/-3

EN 61000-3-2 TEST REPORT 2003/10/16 09:41 AM

Unit: Panel PC

Model No.: PPC-154T

Remarks: Temp: 28 °C Humid: 54%

Operator: Michael Chen

=====

TEST SETUP

Test Freq.:	50.00 Hz.	Test Voltage:	230.0 vac
Waveform :	SINE	Test Time:	2.5 min.
Classification :	CLASS A	Test Type:	STEADY-STATE

Prog. Zo Enabled:	YES	Prog. Zo:	0.000
-------------------	-----	-----------	-------

Motor Driven with Phase Angle Control: NO

Impedance selected: DIRECT

Synthetic R+L Enabled: NO

Resistance: 0.380 Ohms Inductance: 460.000 uH

MAX WATTS: 120.9W



TEST DATA

Result: PASS

Harmonic Current Results

Hn	AMPS	LO Limit	HI Limit	Result
0	0.000	0.000	0.000	PASS
1	0.544	NaN	NaN	PASS
2	0.007	1.080	1.080	PASS
3	0.079	2.300	2.300	PASS
4	0.001	0.430	0.430	PASS
5	0.016	1.140	1.140	PASS
6	0.001	0.300	0.300	PASS
7	0.016	0.770	0.770	PASS
8	0.001	0.230	0.230	PASS
9	0.009	0.400	0.400	PASS
10	0.001	0.184	0.184	PASS
11	0.009	0.330	0.330	PASS
12	0.001	0.153	0.153	PASS
13	0.011	0.210	0.210	PASS
14	0.001	0.131	0.131	PASS
15	0.009	0.150	0.150	PASS
16	0.001	0.115	0.115	PASS
17	0.009	0.132	0.132	PASS
18	0.002	0.102	0.102	PASS
19	0.011	0.118	0.118	PASS
20	0.002	0.092	0.092	PASS



21	0.006	0.107	0.107	PASS
22	0.002	0.084	0.084	PASS
23	0.013	0.098	0.098	PASS
24	0.002	0.077	0.077	PASS
25	0.007	0.090	0.090	PASS
26	0.001	0.071	0.071	PASS
27	0.005	0.083	0.083	PASS
28	0.001	0.066	0.066	PASS
29	0.005	0.078	0.078	PASS
30	0.001	0.061	0.061	PASS
31	0.007	0.073	0.073	PASS
32	0.001	0.058	0.058	PASS
33	0.004	0.068	0.068	PASS
34	0.001	0.054	0.054	PASS
35	0.005	0.064	0.064	PASS
36	0.001	0.051	0.051	PASS
37	0.005	0.061	0.061	PASS
38	0.001	0.048	0.048	PASS
39	0.003	0.058	0.058	PASS
40	0.001	0.046	0.046	PASS

END OF REPORT



EN 61000-3-3 TEST REPORT 2003/10/16 09:56 AM

Unit: Panel PC

Model No.: PPC-154T (Continue)

Remarks: Temp: 28 °C Humid: 54%

Operator: Michael Chen

=====

TEST SETUP

Test Freq.: 50.00 Hz. Test Voltage: 230.0 vac

Waveform : SINE

Test Time: 10.0 min. Tshort: 10.0 min.

Prog. Zo Enabled: YES Prog. Zo: 0.000

Voltage Change less than once per Hour: NO

Impedance selected: DIRECT

Synthetic R+L Enabled: NO

Resistance: 0.380 Ohms Inductance: 460.000 uH



TEST DATA

Result: PASS

	EUT Data	Limit	Result	Test Enabled
Pst max	0.016	1.00	PASS	true
Plt max	0.016	0.65	PASS	true
dc %	0.003	3.00	PASS	true
dmax %	0.004	4.00	PASS	true
d(t) sec.	0.005	0.20	PASS	true
Power Source Data				
Source Pst max	0.020	0.400	PASS	true
% THD	0.030	3.000	PASS	true

END OF REPORT



EN 61000-3-3 TEST REPORT 2003/10/16 10:11 AM

Unit: Panel PC

Model No.: PPC-154T (Manual Switch)

Remarks: Temp: 28 °C Humid: 54%

Operator: Michael Chen

=====

TEST SETUP

Test Freq.: 50.00 Hz. Test Voltage: 230.0 vac

Waveform : SINE

Test Time: 10.0 min. Tshort: 10.0 min.

Prog. Zo Enabled: YES Prog. Zo: 0.000

Voltage Change less than once per Hour: NO

Impedance selected: DIRECT

Synthetic R+L Enabled: NO

Resistance: 0.380 Ohms Inductance: 460.000 uH



TEST DATA

Result: PASS

	EUT Data	Limit	Result	Test Enabled
Pst max	0.025	1.00	PASS	true
Plt max	0.025	0.65	PASS	true
dc %	0.009	3.00	PASS	true
dmax %	0.009	4.00	PASS	true
d(t) sec.	0.008	0.20	PASS	true
Power Source Data				
Source Pst max	0.021	0.400	PASS	true
% THD	0.030	3.000	PASS	true

END OF REPORT